•	Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
09/754,441	YOSHIHARA ET AL.	
Examiner	Art Unit	
Hai V. Nguyen	2142	

SEARCHED			
Class	Subclass	Date	Examiner
709	248	9/6/2005	НΝ
725	87	9/6/2005	HN
84	470R	9/6/2005	HN
84	477R	9/6/2005	HN
			-

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1		
			:

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Search Updated	9/6/2005	HN
Consult with K.S. (AU 2142): the Final Action is improper	9/18/2005	HN